Econometrics 2 - Lecture 3

Univariate Time Series Models

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

Private Consumption



Private Consumption, cont'd



Disposable Income



Time Series

Time-ordered sequence of observations of a random variable

Examples:

- Annual values of private consumption
- Changes in expenditure on private consumption
- Quarterly values of personal disposable income
- Monthly values of imports

Notation:

- Random variable Y
- Sequence of observations Y₁, Y₂, ..., Y_T
- Deviations from the mean: $y_t = Y_t E\{Y_t\} = Y_t \mu$

Components of a Time Series

Components or characteristics of a time series are

- Trend
- Seasonality
- Irregular fluctuations
- Time series model: represents the characteristics as well as possible interactions

Purpose of modeling

- Description of the time series
- Forecasting the future

Example: $Y_t = \beta t + \Sigma_i \gamma_i D_{it} + \varepsilon_t$

with $D_{it} = 1$ if *t* corresponds to *i*-th quarter, $D_{it} = 0$ otherwise for describing the development of the disposable income

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

Stochastic Process

Time series: realization of a stochastic process

Stochastic process is a sequence of random variables Y_t , e.g.,

{
$$Y_t$$
, $t = 1, ..., n$ }
{ Y_t , $t = -\infty, ..., \infty$ }

Joint distribution of the $Y_1, ..., Y_n$:

$$p(y_1, ..., y_n)$$

Of special interest

- Evolution of the expectation $\mu_t = E\{Y_t\}$ over time
- Dependence structure over time

Example: Extrapolation of a time series as a tool for forecasting

White Noise Process

White noise process x_t , $t = -\infty, ..., \infty$

- $E\{x_t\} = 0$
- $V{x_t} = \sigma^2$
- Cov{ x_t , x_{t-s} } = 0 for all (positive or negative) integers s
- i.e., a mean zero, serially uncorrelated, homoskedastic process

AR(1)-Process

States the dependence structure between consecutive observations as

 $Y_{t} = \delta + \theta Y_{t-1} + \varepsilon_{t}, \quad |\theta| < 1$

with ε_t : white noise, i.e., $V{\varepsilon_t} = \sigma^2$ (see next slide)

Autoregressive process of order 1

From
$$Y_t = \delta + \theta Y_{t-1} + \varepsilon_t = \delta + \theta \delta + \theta^2 \delta + \dots + \varepsilon_t + \theta \varepsilon_{t-1} + \theta^2 \varepsilon_{t-2} + \dots$$
 follows

$$E\{Y_t\} = \mu = \delta(1-\theta)^{-1}$$

• $|\theta| < 1$ needed for convergence! Invertibility condition In deviations from μ , $y_t = Y_t - \mu$:

$$y_{t} = \theta y_{t-1} + \varepsilon_{t}$$

AR(1)-Process, cont'd

Autocovariances $\gamma_k = \text{Cov}\{Y_t, Y_{t-k}\}$

•
$$k=0: \gamma_0 = V\{Y_t\} = \theta^2 V\{Y_{t-1}\} + V\{\varepsilon_t\} = \dots = \Sigma_i \theta^{2i} \sigma^2 = \sigma^2 (1-\theta^2)^{-1}$$

•
$$k=1: \gamma_1 = \text{Cov}\{Y_t, Y_{t-1}\} = \mathbb{E}\{(\theta y_{t-1} + \varepsilon_t)y_{t-1}\} = \theta \nabla\{y_{t-1}\} = \theta \sigma^2 (1-\theta^2)^{-1}$$

In general:

$$\gamma_k = \text{Cov}\{Y_t, Y_{t-k}\} = \theta^k \sigma^2 (1-\theta^2)^{-1}, \ k = 0, 1, ...$$

depends upon *k*, not upon *t*!

MA(1)-Process

States the dependence structure between consecutive observations as

 $Y_{t} = \mu + \varepsilon_{t} + \alpha \varepsilon_{t-1}$ with ε_{t} : white noise, $V{\{\varepsilon_{t}\}} = \sigma^{2}$ Moving average process of order 1 $E{Y_{t}} = \mu$

Autocovariances $\gamma_k = Cov\{Y_t, Y_{t-k}\}$

- $k=0: \gamma_0 = V\{Y_t\} = \sigma^2(1+\alpha^2)$
- $k=1: \gamma_1 = Cov\{Y_t, Y_{t-1}\} = \alpha \sigma^2$
- $\gamma_k = 0$ for k = 2, 3, ...
- Depends upon *k*, not upon *t*!

AR-Representation of MA-Process

The AR(1) can be represented as MA-process of infinite order

$$y_t = \Theta y_{t-1} + \varepsilon_t = \sum_{i=0}^{\infty} \Theta^i \varepsilon_{t-i}$$

given that $|\theta| < 1$

Similarly, the AR representation of the MA(1) process

$$y_t = \alpha y_{t-1} - \alpha^2 y_{t-2} + \dots \epsilon_t = \Sigma_{i=0}^{\infty} (-1)^i \alpha^{i+1} y_{t-i-1} + \epsilon_t$$

given that $|\alpha| < 1$

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

Stationary Processes

Refers to the joint distribution of Y_t 's, in particular to second moments

A process is called strictly stationary if its stochastic properties are unaffected by a change of the time origin

 The joint probability distribution at any set of times is not affected by an arbitrary shift along the time axis

Covariance function:

$$\gamma_{t,k} = \text{Cov}\{Y_t, Y_{t+k}\}, k = 0, 1, \dots$$

Properties:

$$\gamma_{t,k} = \gamma_{t,-k}$$

Weak stationary process:

$$E{Y_t} = \mu \text{ for all } t$$

Cov{Y_t, Y_{t+k}} = γ_k , $k = 0$, 1, ... for all t and all k

Also called covariance stationary process

AC and PAC Function

Autocorrelation function (AC function, ACF) Independent of the scale of Y

• For a stationary process:

$$\rho_{k} = \text{Corr}\{Y_{t}, Y_{t-k}\} = \gamma_{k}/\gamma_{0}, \ k = 0, \quad 1, \dots$$

- Properties:
 - $\Box \quad |\rho_k| \le 1$
 - $\Box \quad \rho_k = \rho_{-k}$

$$\rho_0 = 1$$

Correlogram: graphical presentation of the AC function

Partial autocorrelation function (PAC function, PACF):

 $\theta_{kk} = \text{Corr}\{Y_{t}, Y_{t-k} | Y_{t-1}, \dots, Y_{t-k+1}\}, k = 0, 1, \dots$

- θ_{kk} is obtained from $Y_t = \theta_{k0} + \theta_{k1}Y_{t-1} + ... + \theta_{kk}Y_{t-k}$
- Partial correlogram: graphical representation of the PAC function

AC and PAC Function: Examples

Examples for the AC and PAC functions

White noise

$$\rho_0 = \theta_{00} = 1$$

$$\rho_k = \theta_{kk} = 0, \text{ if } k \neq 0$$

• AR(1) process,
$$Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$$

 $\rho_k = \Theta^k, \ k = 0, \quad 1, \dots$

$$\theta_{00} = 1, \ \theta_{11} = \theta, \ \theta_{kk} = 0 \text{ for } k > 1$$

• MA(1) process,
$$Y_t = \mu + \varepsilon_t + \alpha \varepsilon_{t-1}$$

$$\rho_0 = 1, \ \rho_1 = -\alpha/(1 + \alpha^2), \ \rho_k = 0 \ \text{for} \ k > 1$$

PAC function: damped exponential if $\alpha > 0$, otherwise alternating and damped exponential

AC and PAC Function: Estimates

• Estimator for the AC function ρ_k :

$$\mathcal{V}_{k} = \underbrace{\mathcal{Y}_{t} \mathcal{Y}_{t} \mathcal{Y}_{t}}_{,t} \underbrace{\mathcal{Y}_{t} \mathcal{Y}_{t}}_{,t} \underbrace{\mathcalY}_{t}}_{,t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t}}_{,t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t}}_{,t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t}}_{,t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t}}_{,t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_{t}}_{,t} \underbrace{\mathcalY}_{t} \underbrace{\mathcalY}_$$

= Estimator for the PAC function θ_{kk} : coefficient of Y_{t-k} in the regression of Y_t on Y_{t-1} , ..., Y_{t-k}

AR(1) Processes, Verbeek, Fig. 8.1



Figure 8.1 First-order autoregressive processes: data series and autocorrelation functions

MA(1) Processes, Verbeek, Fig. 8.2



Figure 8.2 First-order moving average processes: data series and autocorrelation functions

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

The ARMA(p,q) Process

Generalization of the AR and MA processes: ARMA(p,q) process

$$y_t = \theta_1 y_{t-1} + \ldots + \theta_p y_{t-p} + \varepsilon_t + \alpha_1 \varepsilon_{t-1} + \ldots + \alpha_q \varepsilon_{t-q}$$

with white noise ϵ_t

Lag (or shift) operator L ($Ly_t = y_{t-1}$, $L^0y_t = Iy_t = y_t$, $L^py_t = y_{t-p}$) ARMA(p,q) process in operator notation

 $\theta(L)y_t = \alpha(L)\varepsilon_t$

with operator polynomials $\theta(L)$ and $\alpha(L)$

$$\theta(L) = I - \theta_1 L - \dots - \theta_p L^p$$

$$\alpha(L) = I + \alpha_1 L + \dots + \alpha_q L^q$$

Lag Operator

Lag (or shift) operator L

- $Ly_t = y_{t-1}, L^0y_t = Iy_t = y_t, L^py_t = y_{t-p}$
- Algebra of polynomials in *L* like algebra of variables
 Examples:

•
$$(I - \phi_1 L)(I - \phi_2 L) = I - (\phi_1 + \phi_2)L + \phi_1 \phi_2 L^2$$

$$(I - \Theta L)^{-1} = \Sigma_{i=0}^{\infty} \Theta^{i} L^{i}$$

• $MA(\infty)$ representation of the AR(1) process

$$y_t = (I - \Theta L)^{-1} \varepsilon_t$$

the infinite sum defined only (e.g., finite variance) $|\theta| < 1$

• MA(∞) representation of the ARMA(p,q) process

 $y_t = [\Theta(L)]^{-1}\alpha(L)\varepsilon_t$

similarly the $AR(\infty)$ representations; invertibility condition: restrictions on parameters

Invertibility of Lag Polynomials

Invertibility condition for $I - \theta L$: $|\theta| < 1$ Invertibility condition for $I - \theta_1 L - \theta_2 L^2$:

- $\theta(L) = I \theta_1 L \theta_2 L^2 = (I \phi_1 L)(I \phi_2 L)$ with $\phi_1 + \phi_2 = \theta_1$ and $-\phi_1 \phi_2 = \theta_2$
- Invertibility conditions: both $(I \phi_1 L)$ and $(I \phi_2 L)$ invertible; $|\phi_1| < 1$, $|\phi_2| < 1$
- Characteristic equation: $\theta(z) = (1 \phi_1 z) (1 \phi_2 z) = 0$
- Characteristic roots: solutions z_1 , z_2 from $(1 \phi_1 z) (1 \phi_2 z) = 0$
- Invertibility conditions: $|z_1| > 1$, $|z_2| > 1$

Can be generalized to lag polynomials of higher order Unit root: a characteristic root of value 1

- Polynomial $\theta(z)$ evaluated at z = 1: $\theta(1) = 0$, if $\Sigma_i \theta_i = 1$
- Simple check, no need to solve characteristic equation

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

Types of Trend

- Trend: The expected value of a process Y_t increases or decreases with time
- Deterministic trend: a function f(t) of the time, describing the evolution of E{Y_t} over time

 $Y_t = f(t) + \varepsilon_t, \varepsilon_t$: white noise

Example: $Y_t = \alpha + \beta t + \varepsilon_t$ describes a linear trend of *Y*; an increasing trend corresponds to $\beta > 0$

• Stochastic trend: $Y_t = \delta + Y_{t-1} + \varepsilon_t$ or

 $\Delta Y_t = Y_t - Y_{t-1} = \delta + \varepsilon_t$, ε_t : white noise

- $\hfill \Delta Y_t$ around fluctuation of the differences ΔY_t around the expected value δ
- AR(1) or AR(p) process with unit root
- "random walk with trend"

Example: Private Consumption

Private consumption, AWM database; level values (PCR) and first differences (PCR_D)



Trends: Random Walk and AR Process

Random walk: $Y_t = Y_{t-1} + \varepsilon_t$; random walk with trend: $Y_t = 0.1 + Y_{t-1} + \varepsilon_t$; AR(1) process: $Y_t = 0.2 + 0.7Y_{t-1} + \varepsilon_t$; ε_t simulated from N(0,1)



Random Walk with Trend

The random walk with trend $Y_t = \delta + Y_{t-1} + \varepsilon_t$ can be written as

 $Y_t = Y_0 + \delta t + \Sigma_{i \le t} \varepsilon_i$

δ: trend parameter

Components of the process

- Deterministic growth path $Y_0 + \delta t$
- Cumulative errors $\Sigma_{i\leq t} \epsilon_i$

Properties:

- Expectation $Y_0 + \delta t$ is not a fixed value!
- $V{Y_t} = \sigma^2 t$ becomes arbitrarily large!
- Corr{ Y_t, Y_{t-k} } = $\sqrt{(1-k/t)}$
- Non-stationarity

Random Walk with Trend, cont'd

From

$$Cor Y_t, Y_{t-1} = -$$

follows

- For fixed k, Y_t and Y_{t-k} are the stronger correlated, the larger t
- With increasing k, correlation tends to zero, but the slower the larger t (long memory property)

Comparison of random walk with the AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$

- AR(1) process: ε_{t-i} has the lesser weight, the larger *i*
- AR(1) process similar to random walk when θ is close to one

Non-Stationarity: Consequences

AR(1) process $Y_t = \theta Y_{t-1} + \varepsilon_t$

OLS Estimator for θ:



- For $|\theta| < 1$: the estimator is
 - Consistent
 - Asymptotically normally distributed
- For $\theta = 1$ (unit root)
 - θ is underestimated
 - Estimator not normally distributed
 - Spurious regression problem

Spurious Regression

Random walk without trend: $Y_t = Y_{t-1} + \varepsilon_t$, ε_t : white noise

- Realization of Y_t: is a non-stationary process, stochastic trend?
- V{Y_t}: a multiple of t
- Specified model: $Y_t = \alpha + \beta t + \varepsilon_t$
- Deterministic trend
- Constant variance
- Misspecified model!

Consequences for OLS estimator for $\boldsymbol{\beta}$

- *t* and *F*-statistics: wrong critical limits, rejection probability too large
- R² indicates explanatory potential although Y_t random walk without trend
- Granger & Newbold, 1974

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

How to Model Trends?

Specification of

- Deterministic trend, e.g., $Y_t = \alpha + \beta t + \varepsilon_t$: risk of wrong decisions
- Stochastic trend: analysis of differences ΔY_t if a random walk, i.e., a unit root, is suspected
- Consequences of spurious regression are more serious

Consequences of modeling differences ΔY_t :

- Autocorrelated errors
- Consistent estimators
- Asymptotically normally distributed estimators
- HAC correction of standard errors

Elimination of a Trend

In order to cope with non-stationarity

- Trend-stationary process: the process can be transformed in a stationary process by subtracting the deterministic trend
- Difference-stationary process, or integrated process: stationary process can be derived by differencing

Integrated process: stochastic process Y is called

- integrated of order one if the first differences yield a stationary process: $Y \sim I(1)$
- integrated of order *d*, if the *d*-fold differences yield a stationary process: Y ~ I(d)

Trend-Elimination: Examples

Random walk $Y_t = \delta + Y_{t-1} + \varepsilon_t$ with white noise ε_t

 $\Delta Y_{t} = Y_{t} - Y_{t-1} = \delta + \varepsilon_{t}$

- ΔY_t is a stationary process
- A random walk is a difference-stationary or *I*(1) process

Linear trend $Y_t = \alpha + \beta t + \varepsilon_t$

- Subtracting the trend component α + βt provides a stationary process
- Y_t is a trend-stationary process

Integrated Stochastic Processes

Random walk $Y_t = \delta + Y_{t-1} + \varepsilon_t$ with white noise ε_t is a differencestationary or I(1) process

Many economic time series show stochastic trends

From the AWM Database

	Variable	d
YER	GDP, real	1
PCR	Consumption, real	1-2
PYR	Household's Disposable Income, real	1-2
PCD	Consumption Deflator	2

ARIMA(*p*,*d*,*q*) process: *d*-th differences follow an ARMA(*p*,*q*) process

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

Unit Root Tests

AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$ with white noise ε_t

- Dickey-Fuller or DF test (Dickey & Fuller, 1979) Test of H_0 : θ = 1 against H_1 : θ < 1</p>
- KPSS test (Kwiatkowski, Phillips, Schmidt & Shin, 1992) Test of H_0 : θ < 1 against H_1 : θ = 1
- Augmented Dickey-Fuller or ADF test extension of DF test
- Various modifications like Phillips-Perron test, Dickey-Fuller GLS test, etc.

Dickey-Fuller's Unit Root Test

AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$ with white noise ε_t OLS Estimator for θ :

$$\hat{\theta} \stackrel{\cdot}{\rightarrow} \mathcal{Y}_{t} \mathcal{Y}_{t-1}^{1}$$

Distribution of DF

• If $|\theta| < 1$: approximately t(T-1)

If θ = 1: Dickey & Fuller critical values

DF test for testing H_0 : $\theta = 1$ against H_1 : $\theta < 1$

• $\theta = 1$: characteristic polynomial has unit root

Dickey-Fuller Critical Values

Monte Carlo estimates of critical values for

- *DF*₀: Dickey-Fuller test without intercept
- DF: Dickey-Fuller test with intercept
- DF_{T} : Dickey-Fuller test with time trend

Τ		<i>p</i> = 0.01	<i>p</i> = 0.05	<i>p</i> = 0.10
25	DF_0	-2.66	-1.95	-1.60
	DF	-3.75	-3.00	-2.63
	DF_{τ}	-4.38	-3.60	-3.24
100	DF_0	-2.60	-1.95	-1.61
	DF	-3.51	-2.89	-2.58
	DF_{τ}	-4.04	-3.45	-3.15
N(0,1)		-2.33	-1.65	-1.28

Unit Root Test: The Practice

AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$ with white noise ε_t can be written with $\pi = \theta - 1$ as $\Delta Y_t = \delta + \pi Y_{t-1} + \varepsilon_t$ DF tests H_0 : $\pi = 0$ against H_1 : $\pi < 0$ test statistic for testing $\pi = \theta - 1 = 0$ identical with *DF* statistic $DI = \int_{\kappa D} = \int_{\kappa D} \mathcal{T}_{\kappa D}$

Two steps:

- **1.** Regression of ΔY_t on Y_{t-1} : OLS-estimator for $\pi = \theta 1$
- 2. Test of H_0 : $\pi = 0$ against H_1 : $\pi < 0$ based on *DF*; critical values of Dickey & Fuller

Example: Price/Earnings Ratio

Verbeek's data set PE: annual time series data on composite stock price and earnings indices of the S&P500, 1871-2002

PE: price/earnings ratio



Price/Earnings Ratio, cont'd

Fitting an AR(1) process to the log PE ratio data gives:

 $\Delta Y_{t} = 0.335 - 0.125 Y_{t-1}$

with *t*-statistic -2.569 (Y_{t-1}) and *p*-value 0.1021

- *p*-value of the DF statistic (-2.569): 0.102
 - 1% critical value: -3.48
 - □ 5% critical value: -2.88
 - 10% critical value: -2.58
- $H_0: \theta = 1$ (non-stationarity) cannot be rejected for the log PE ratio

Unit root test for first differences: DF statistic -7.31, *p*-value 0.000 (1% critical value: -3.48)

log PE ratio is *l*(1)

However: for sample 1871-1990: DF statistic -3.65, p-value 0.006

Unit Root Test: Extensions

DF test so far for a model with intercept: $\Delta Y_t = \delta + \pi Y_{t-1} + \varepsilon_t$ Tests for alternative or extended models

• DF test for model without intercept: $\Delta Y_t = \pi Y_{t-1} + \varepsilon_t$

DF test for model with intercept and trend: $\Delta Y_t = \delta + \gamma t + \pi Y_{t-1} + \varepsilon_t$ DF tests in all cases H_0 : π = 0 against H_1 : π < 0

Test statistic in all cases

$$DI = \begin{bmatrix} - & \\ \mathbf{r}_{A} \end{bmatrix}$$
Critical values depend on cases; cf. Table on slide 42

KPSS Test

A process $Y_t = \delta + \varepsilon_t$ with white noise ε_t

- Test of H_0 : no unit root (Y_t is stationary), against H_1 : $Y_t \sim I(1)$
- Under H_0 :
 - Average \dot{y} is a consistent estimate of δ
 - Long-run variance of ε_t is a well-defined number
- KPSS (Kwiatkowski, Phillips, Schmidt, Shin) test statistic



with $S_t^2 = \Sigma_i^t e_i$ and the variance estimate s^2 of the residuals $e_i = Y_t - \dot{y}$

Bandwidth or lag truncation parameter *m* for estimating s²

$$S^2 = \mathbf{\nabla}$$

Critical values from Monte Carlo simulations

ADF Test

Extended model according to an AR(*p*) process:

 $\Delta Y_{t} = \delta + \pi Y_{t-1} + \beta_{1} \Delta Y_{t-1} + \dots + \beta_{p} \Delta Y_{t-p+1} + \varepsilon_{t}$ Example: AR(2) process $Y_{t} = \delta + \theta_{1} Y_{t-1} + \theta_{2} Y_{t-2} + \varepsilon_{t}$ can be written as $\Delta Y_{t} = \delta + (\theta_{1} + \theta_{2} - 1) Y_{t-1} - \theta_{2} \Delta Y_{t-1} + \varepsilon_{t}$ the characteristic equation $(1 - \phi_{1}L)(1 - \phi_{2}L) = 0$ has roots $\theta_{1} = \phi_{1} + \phi_{2}$ and $\theta_{2} = -\phi_{1}\phi_{2}$ a unit root implies $\phi_{1} = \theta_{1} + \theta_{2} = 1$: Augmented DF (ADF) test

- Test of H_0 : $\pi = 0$ against H_1 : $\pi < 0$
- Needs its own critical values
- Extensions (intercept, trend) similar to the DF-test
- Phillips-Perron test: alternative method; uses HAC-corrected standard errors

Price/Earnings Ratio, cont'd

Extended model according to an AR(2) process gives:

 $\Delta Y_{t} = 0.366 - 0.136 Y_{t-1} + 0.152 \Delta Y_{t-1} - 0.093 \Delta Y_{t-2}$

with *t*-statistics -2.487 (Y_{t-1}), 1.667 (ΔY_{t-1}) and -1.007 (ΔY_{t-2}) and

p-values 0.119, 0.098 and 0.316

- p-value of the DF statistic 0.121
 - a 1% critical value: -3.48
 - □ 5% critical value: -2.88
 - 10% critical value: -2.58
- Non-stationarity cannot be rejected for the log PE ratio
- Unit root test for first differences: DF statistic -7.31, *p*-value 0.000 (1% critical value: -3.48)
- Iog PE ratio is I(1)

However: for sample 1871-1990: DF statistic -3.52, p-value 0.009

Unit Root Tests in GRETL

For marked variable:

- Variable > Unit root tests > Augmented Dickey-Fuller test
 Performs the
 - DL test (choose zero for "lag order for ADL test") or the
 - ADL test
 - with or without constant, trend, squared trend
- Variable > Unit root tests > ADF-GLS test

Performs the

- DL test (choose zero for "lag order for ADL test") or the
- ADL test
- with or without a trend, which are estimated by GLS
- Variable > Unit root tests > KPSS test

Performs the KPSS test with or without a trend

Contents

- Time Series
- Stochastic Processes
- Stationary Processes
- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

ARMA Models: Application

Application of the ARMA(p,q) model in data analysis: Three steps

- 1. Model specification, i.e., choice of *p*, *q* (and *d* if an ARIMA model is specified)
- 2. Parameter estimation
- 3. Diagnostic checking

Estimation of ARMA Models

The estimation methods are

- OLS estimation
- ML estimation

AR models: the explanatory variables are

- Lagged values of the explained variable Y_t
- Uncorrelated with error term ε_t
- OLS estimation

MA Models: OLS Estimation

MA models:

- Minimization of sum of squared deviations is not straightforward
- E.g., for an MA(1) model, $S(\mu, \alpha) = \Sigma_t [Y_t \mu \alpha \Sigma_{j=0} (-\alpha)^j (Y_{t-j-1} \mu)]^2$
 - \Box S(μ, α) is a nonlinear function of parameters
 - Needs Y_{t-j-1} for j=0,1,..., i.e., historical Y_s , s < 0
- Approximate solution from minimization of

 $S^{*}(\mu, \alpha) = \sum_{t} [Y_{t} - \mu - \alpha \sum_{j=0}^{t-2} (-\alpha)^{j} (Y_{t-j-1} - \mu)]^{2}$

Nonlinear minimization, grid search

ARMA models combine AR part with MA part

ML Estimation

Assumption of normally distributed ε_t

Log likelihood function, conditional on initial values

log L(α,θ,μ,σ²) = - (*T*-1)log(2πσ²)/2 - (1/2) Σ_t ε_t²/σ²

 $\boldsymbol{\epsilon}_t$ are functions of the parameters

• AR(1):
$$\varepsilon_{t} = y_{t} - \theta_{1}y_{t-1}$$

• MA(1):
$$\varepsilon_t = \sum_{j=0}^{t-1} (-\alpha)^j y_{t-j}$$

Initial values: y_1 for AR, $\varepsilon_0 = 0$ for MA

- Extension to exact ML estimator
- Again, estimation for AR models easier
- ARMA models combine AR part with MA part

Model Specification

Based on the

- Autocorrelation function (ACF)
- Partial Autocorrelation function (PACF)

Structure of AC and PAC functions typical for AR and MA processes Example:

- MA(1) process: $\rho_0 = 1$, $\rho_1 = \alpha/(1-\alpha^2)$; $\rho_i = 0$, $i = 2, 3, ...; \theta_{kk} = \alpha^k$, k = 0, 1, ...
- AR(1) process: $\rho_k = \theta^k$, $k = 0, 1, ...; \theta_{00} = 1, \theta_{11} = \theta, \theta_{kk} = 0$ for k > 1

Empirical ACF and PACF give indications on the process underlying the time series

ARMA(*p*,*q*)-Processes

Condition for	$\begin{array}{l} \mathbf{AR}(\boldsymbol{p}) \\ \boldsymbol{\theta}(L) \boldsymbol{Y}_{t} = \boldsymbol{\varepsilon}_{t} \end{array}$	MA(q) $Y_t = \alpha(L) \epsilon_t$	ARMA(<i>p</i>,<i>q</i>) θ(L) Y_t =α(L) ε _t
Stationarity	roots z_i of $\theta(z)=0: z_i > 1$	always stationary	roots z_i of $\theta(z)=0: z_i > 1$
Invertibility	always invertible	roots z_i of $\alpha(z)=0: z_i > 1$	roots z_i of $\alpha(z)=0: z_i > 1$
AC function	damped, infinite	ρ _k = 0 for <i>k</i> > <i>q</i>	damped, infinite
PAC function	$ \theta_{kk} = 0 \text{ for } k > p $	damped, infinite	damped, infinite

Empirical AC and PAC Function

Estimation of the AC and PAC functions

AC ρ_k :

$$\mathcal{V}_{k} = \underbrace{\mathcal{Y}_{t} \ \mathcal{Y}_{t} \ \mathcal{Y}_{t$$

PAC θ_{kk} : coefficient of Y_{t-k} in regression of Y_t on Y_{t-1} , ..., Y_{t-k} MA(*q*) process: standard errors for r_k , k > q, from

$$\sqrt{T}(r_k - \rho_k) \rightarrow N(0, v_k)$$

with $v_k = 1 + 2\rho_1^2 + \dots + 2\rho_k^2$

test of H₀: ρ₁ = 0: compare √Tr₁ with critical value from N(0,1), etc.
 AR(p) process: test of H₀: ρ_k = 0 for k > p based on asymptotic distribution

 $\sqrt{T_{\theta}} \rightarrow 1$

Diagnostic Checking

ARMA(p,q): Adequacy of choices p and q

Analysis of residuals from fitted model:

- Correct specification: residuals are realizations of white noise
- Box-Ljung Portmanteau test: for a ARMA(p,q) process

$$Q_{k} = T(T_{+}2) \sum_{k=1}^{K} T_{k}^{1} k^{k}$$

follows the Chi-squared distribution with K-p-q df

Overfitting

- Starting point: a general model
- Comparison with a model with reduced number of parameters: choose model with smallest *BIC* or *AIC*
- *AIC*: tends to result asymptotically in overparameterized models

Example: Price/Earnings Ratio



PE Ratio: AC and PAC Function



PE Ratio: MA (4) Model

MA(4) model for dif	fferences	log PE _t - I	og PE _{t-1}				
Function evaluations: 37 Evaluations of gradient: 11							
	Model 2: ARMA, using observations 1872-2002 (T = 131) Estimated using Kalman filter (exact ML) Dependent variable: d_LOGPE Standard errors based on Hessian						
		coefficient	std. error	t-ratio	p-value		
	const theta_1 theta_2 theta_3 theta_4	0,00804276 0,0478900 -0,187566 -0,0400834 -0,146218	0,0104120 0,0864653 0,0913502 0,0819391 0,0915800	0,7725 0,5539 -2,053 -0,4892 -1,597	0,4398 0,5797 0,0400 ** 0,6247 0,1104		
	Mean depen Mean of innc Log-likelihoo Schwarz crite	dent var ovations d erion	0,008716 -0,000308 42,69439 -56,13759	S.D. depen S.D. of inno Akaike crite Hannan-Qu	dent var ovations erion uinn	0,181506 0,174545 -73,38877 -66,37884	

PE Ratio: AR(4) Model

AR(4) model for differences log $PE_t - \log PE_{t-1}$							
	Function evaluations: 36 Evaluations of gradient: 9						
	Model 3: ARMA, using observations 1872-2002 (T = 131) Estimated using Kalman filter (exact ML) Dependent variable: d_LOGPE Standard errors based on Hessian						
		coefficient	std. error	t-ratio	p-value		
	const phi_1	0,00842210 0,0601061	0,0111324 0,0851737 0,0856482	0,7565 0,7057	0,4493 0,4804 0.0178 **		
	phi_2 phi_3 phi_4	-0,0228251 -0,206655	0,0853236 0,0850843	-0,2675 -2,429	0,7891 0,0151 **		
	Mean de Mean of Log-likel Schwarz	ependent var innovations ihood c criterion	0,008716 -0,000315 43,35448 -57,45778	S.D. depe S.D. of inr Akaike cri Hannan-C	ndent var novations terion Quinn	0,181506 0,173633 -74,70896 -67,69903	

PE Ratio: Various Models

Diagnostics for various competing models: $\Delta y_t = \log PE_t - \log PE_{t-1}$ Best fit for

- BIC: MA(2) model $\Delta y_t = 0.008 + e_t 0.250 e_{t-2}$
- AIC: AR(2,4) model $\Delta y_t = 0.008 0.202 \Delta y_{t-2} 0.211 \Delta y_{t-4} + e_t$

Model	Lags	AIC	BIC	Q ₁₂	<i>p</i> -value
MA(4)	1–4	-73.389	-56.138	5.03	0.957
AR(4)	1–4	-74.709	-57.458	3.74	0.988
MA	2, 4	-76.940	-65.440	5.48	0.940
AR	2, 4	-78.057	-66.556	4.05	0.982
MA	2	-76.072	-67.447	9.30	0.677
AR	2	-73.994	-65.368	12.12	0.436

Time Series Models in GRETL

- Variable > Unit root tests > (a) Augmented Dickey-Fuller test, (b) ADL-GLS test, (c) KPSS test
- a) DF test or ADL test with or without constant, trend and squared trend
- b) DF test or ADL test with or without trend, GLS estimation for demeaning and detrending
- c) KPSS (Kwiatkowski, Phillips, Schmidt, Shin) test
- Model > Time Series > ARIMA
- Estimates an ARMA model, with or without exogenous regressors

Your Homework

- Use Verbeek's data set INCOME (quarterly data for the total disposable income and for consumer expenditures for 1/1971 to 2/1985 in the UK) and answer the questions a., b., c., d., e., and f. of Exercise 8.3 of Verbeek. Confirm your finding in question c. using the KPSS test.
- 2. For the AR(2) model $y_t = \theta_1 y_{t-1} + \theta_2 y_{t-2} + \varepsilon_t$, show that (a) the model can be written as $\Delta y_t = \delta y_{t-1} \theta_2 \Delta y_{t-1} + \varepsilon_t$ with $\delta = \theta_1 + \theta_2 1$, and that (b) $\theta_1 + \theta_2 = 1$ corresponds to a unit root of the characteristic equation $\theta(z) = 1 \theta_1 z \theta_2 z^2 = 0$.